S arch Notes

Application/Control No.	Applicant(s)/Patent under Re xamination
10/500,067	LEE ET AL.
Examiner	Art Unit
Christopher PoDee	1756

	SEAR	CHED	
Class	Subclass	Date	Examiner
430	106.1 106.3 108.6 108.7	6/20/2006	CDR

INT	ERFERENC	E SEARCH	ED
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East search as enclosed	6/20/2006	CDR		